Search Notes				

Application/Control No.	Applicant(s)/Patent unde Reexamination	Applicant(s)/Patent under Reexamination	
10/543,190	TATEMATSU ET AL.	TATEMATSU ET AL.	
Examiner	Art Unit		
Huan H. Tran	2861		

	OFAROUER					
SEARCHED						
Class	Subclass	Date	Examiner			
347	212,155 156	1/4/2007	ННТ			
399	320,322	1/4/2007	ННТ			
399	323	1/4/2007	ннт			
updated		4/26/2007	ннт			
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
		:		
		Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
(347/212,155,156 or 399/320,322,323).ccls.	1/4/2007	ннт	
g03g015/20.ipc.	1/4/2007	ннт	
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